Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/867,058	BEYDA ET AL.	
Examiner	Art Unit	
Joseph T. Phan	2645	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East Search History Attached	3/9/2006	JTP	
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